4M High Speed SRAM (512-kword × 8-bit)

# HITACHI

ADE-203-1035A (Z) Rev. 1.0 Apr. 15, 1999

#### **Description**

The HM628511HI Series is a 4-Mbit high speed static RAM organized 512-k word  $\times$  8-bit. It has realized high speed access time by employing CMOS process (4-transistor + 2-poly resistor memory cell)and high speed circuit designing technology. It is most appropriate for the application which requires high speed, high density memory and wide bit width configuration, such as cache and buffer memory in system. It is packaged in 400-mil 36-pin plastic SOJ.

#### **Features**

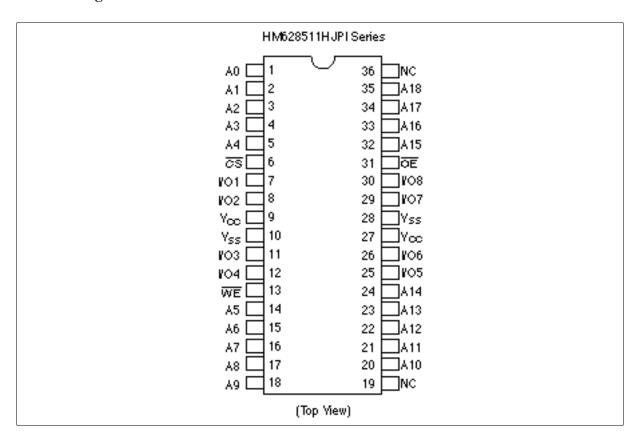
- Single 5.0 V supply :  $5.0 \text{ V} \pm 10 \%$
- Access time 12/15 ns (max)
- Completely static memory
  - No clock or timing strobe required
- Equal access and cycle times
- Directly TTL compatible
  - All inputs and outputs
- Operating current: 160 / 140 mA (max)
- TTL standby current: 60 / 50 mA (max)
- CMOS standby current: 5 mA (max)
- Center V<sub>CC</sub> and V<sub>SS</sub> type pinout
- Temperature range: -40 to 85°C



## **Ordering Information**

Type No.	Access time	Package
HM628511HJPI-12	12 ns	400-mil 36-pin plastic SOJ (CP-36D)
HM628511HJPI-15	15 ns	

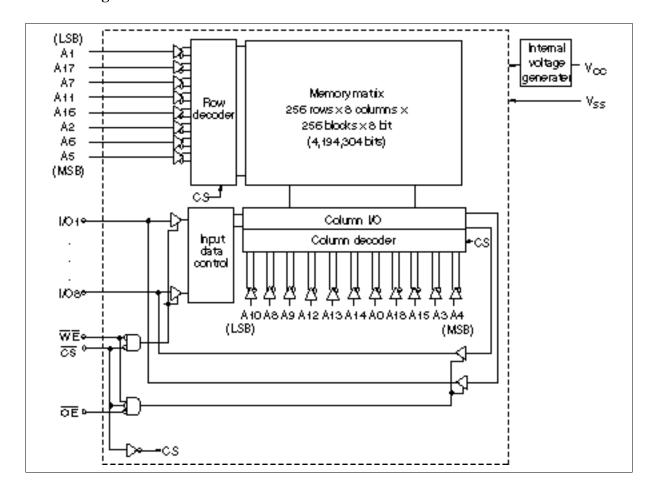
## **Pin Arrangement**



## **Pin Description**

Pin name	Function
A0 to A18	Address input
I/O1 to I/O8	Data input/output
CS	Chip select
OE	Output enable
WE	Write enable
Vcc	Power supply
V <sub>SS</sub>	Ground
NC	No connection

## **Block Diagram**



## **Operation Table**

CS	OE	WE	Mode	V <sub>CC</sub> current	I/O	Ref. cycle
Н	×	×	Standby	I <sub>SB</sub> , I <sub>SB1</sub>	High-Z	_
L	Н	Н	Output disable	I <sub>CC</sub>	High-Z	_
L	L	Н	Read	I <sub>CC</sub>	Dout	Read cycle (1) to (3)
L	Н	L	Write	Icc	Din	Write cycle (1)
L	L	L	Write	I <sub>CC</sub>	Din	Write cycle (2)

Note: x: H or L

## **Absolute Maximum Ratings**

Parameter	Symbol	Value	Unit	
Supply voltage relative to V <sub>SS</sub>	Vcc	-0.5 to +7.0	V	
Voltage on any pin relative to V <sub>SS</sub>	V <sub>T</sub>	$-0.5^{*1}$ to $V_{CC}+0.5^{*2}$	V	
Power dissipation	P <sub>T</sub>	1.0	W	
Operating temperature	Topr	-40 to +85	°C	
Storage temperature	Tstg	-55 to +125	°C	
Storage temperature under bias	Tbias	-40 to +85	°C	

Notes: 1.  $V_T$  (min) = -2.0 V for pulse width (under shoot) 8 ns

2.  $V_T$  (max) =  $V_{CC}$ +2.0 V for pulse width (over shoot) 8 ns

## **Recommended DC Operating Conditions** ( $Ta = -40 \text{ to } +85^{\circ}\text{C}$ )

Parameter	Symbol	Min	Тур	Max	Unit
Supply voltage	Vcc*3	4.5	5.0	5.5	V
	Vss*4	0	0	0	V
Input voltage	V <sub>IH</sub>	2.2	_	$V_{CC} + 0.5^{*2}$	V
	V <sub>IL</sub>	-0.5* <sup>1</sup>	_	0.8	V

Notes: 1.  $V_{IL}$  (min) = -2.0 V for pulse width (under shoot) 8 ns

- 2.  $V_{IH}$  (max) =  $V_{CC}$ +2.0 V for pulse width (over shoot) 8 ns
- 3. The supply voltage with all  $V_{CC}$  pins must be on the same level.
- 4. The supply voltage with all V<sub>SS</sub> pins must be on the same level.

## **DC Characteristics** (Ta = -40 to +85°C, $V_{CC} = 5.0$ V $\pm 10$ %, $V_{SS} = 0$ V)

Parameter		Symbol	Min	Typ* <sup>1</sup>	Max	Unit	Test conditions
Input leakage current		II <sub>LI</sub> I	_	_	2	μΑ	Vin = V <sub>SS</sub> to V <sub>CC</sub>
Output leakage current		II <sub>LO</sub> I	_	_	2	μΑ	Vin = V <sub>SS</sub> to V <sub>CC</sub>
Operation power supply current	12 ns cycle	I <sub>CC</sub>	_	_	160	mA	Min cycle CS = V <sub>IL</sub> , lout = 0 mA Other inputs = V <sub>IH</sub> /V <sub>IL</sub>
	15 ns cycle	I <sub>CC</sub>	_	_	140	_	
Standby power supply current	12 ns cycle	I <sub>SB</sub>	_	_	60	mA	Min cycle, $CS = V_{IH}$ , Other inputs = $V_{IH}/V_{IL}$
	15 ns cycle	I <sub>SB</sub>	_	_	50	_	
		I <sub>SB1</sub>	_	0.1	5	mA	f = 0 MHz V <sub>CC</sub> CS V <sub>CC</sub> - 0.2 V, (1) 0 V Vin 0.2 V or (2) V <sub>CC</sub> Vin V <sub>CC</sub> - 0.2 V
Output voltage		$V_{OL}$	_	_	0.4	V	I <sub>OL</sub> = 8 mA
		V <sub>OH</sub>	2.4	_	_	V	$I_{OH} = -4 \text{ mA}$

Notes: 1. Typical values are at  $V_{CC} = 5.0 \text{ V}$ ,  $Ta = +25^{\circ}\text{C}$  and not guaranteed.

## **Capacitance** (Ta = +25°C, f = 1.0 MHz)

Parameter	Symbol	Min	Тур	Max	Unit	Test conditions
Input capacitance*1	Cin	_	_	6	pF	Vin = 0 V
Input/output capacitance*1	C <sub>I/O</sub>		_	8	pF	V <sub>I/O</sub> = 0 V

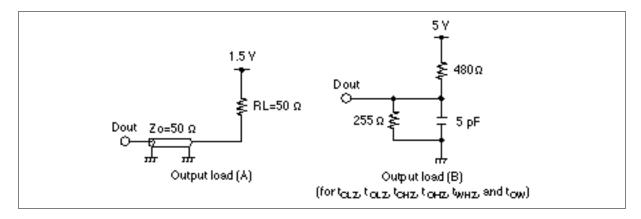
Note: 1. This parameter is sampled and not 100% tested.

AC Characteristics (Ta = -40 to +85°C,  $V_{CC} = 5.0 \text{ V} \pm 10 \text{ \%}$ , unless otherwise noted.)

#### **Test Conditions**

Input pulse levels: 3.0 V/0.0 VInput rise and fall time: 3 ns

Input and output timing reference levels: 1.5 V
Output load: See figures (Including scope and jig)



#### Read Cycle

		11111020011111						
		-12		-15				
Parameter	Symbol	Min	Max	Min	Max	Unit	Notes	
Read cycle time	t <sub>RC</sub>	12	_	15	_	ns		
Address access time	t <sub>AA</sub>	_	12	_	15	ns		
Chip select access time	t <sub>ACS</sub>	_	12	_	15	ns		
Output enable to outpput valid	t <sub>OE</sub>	_	6	_	7	ns		
Output hold from address change	t <sub>OH</sub>	3	_	3	_	ns		
Chip select to output in low-Z	t <sub>CLZ</sub>	3	_	3	_	ns	1	
Output enable to output in low-Z	t <sub>OLZ</sub>	0	_	0	_	ns	1	
Chip deselect to output in high-Z	t <sub>CHZ</sub>	_	6	_	7	ns	1	
Output disable to output in high-Z	t <sub>OHZ</sub>	_	6	_	7	ns	1	

HM628511HI

#### Write Cycle

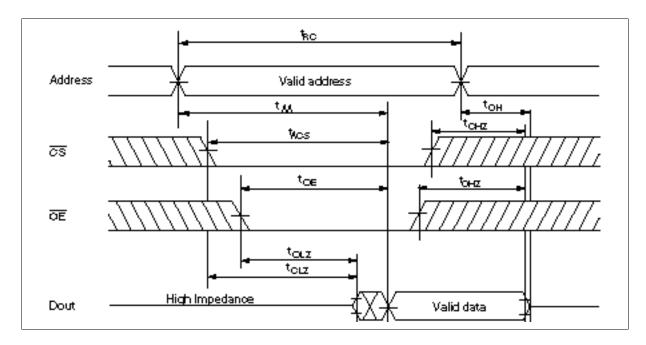
		HM628	8511HI				
		-12		-15			
Parameter	Symbol	Min	Max	Min	Max	Unit	Notes
Write cycle time	twc	12	_	15	_	ns	
Address valid to end of write	t <sub>AW</sub>	8	_	10	_	ns	
Chip select to end of write	tcw	8	_	10	_	ns	9
Write pulse width	t <sub>WP</sub>	8	_	10	_	ns	8
Address setup time	t <sub>AS</sub>	0	_	0	_	ns	6
Write recovery time	t <sub>WR</sub>	0	_	0	_	ns	7
Data to write time overlap	$t_{DW}$	6	_	7	_	ns	
Data hold from write time	t <sub>DH</sub>	0	_	0	_	ns	
Write disable to output in low-Z	tow	3	_	3	_	ns	1
Output disable to output in high-Z	t <sub>OHZ</sub>	_	6	_	7	ns	1
Write enable to output in high-Z	t <sub>WHZ</sub>		6		7	ns	1

Note: 1. Transition is measured ±200 mV from steady voltage with Load (B). This parameter is sampled and not 100% tested.

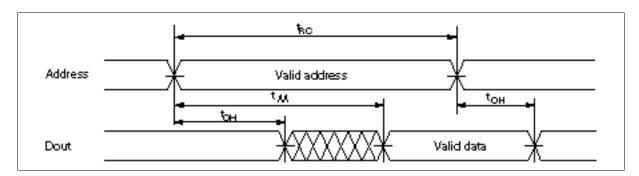
- 2. Address should be valid prior to or coincident with CS transition low.
- 3. WE and/or CS must be high during address transition time.
- 4. if CS and OE are low during this period, I/O pins are in the output state. Then, the data input signals of opposite phase to the outputs must not be applied to them.
- 5. If the CS low transition occurs simultaneously with the WE low transition or after the WE transition, output remains a high impedance state.
- 6.  $t_{AS}$  is measured from the latest address transition to the later of CS or WE going low.
- 7. twR is measured from the earlier of CS or WE going high to the first address transition.
- 8. A write occurs during the overlap of a low CS and a low WE. A write begins at the latest transition among CS going low and WE going low. A write ends at the earliest transition among CS going high and WE going high.  $t_{WP}$  is measured from the beginning of write to the end of write.
- 9. t<sub>CW</sub> is measured from the later of CS going low to the the end of write.

## **Timing Waveforms**

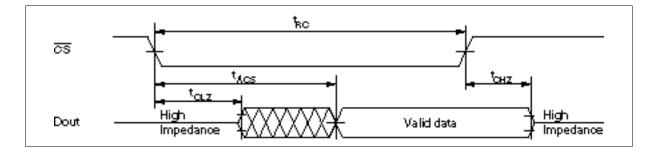
Read Timing Waveform (1) (WE =  $V_{IH}$ )



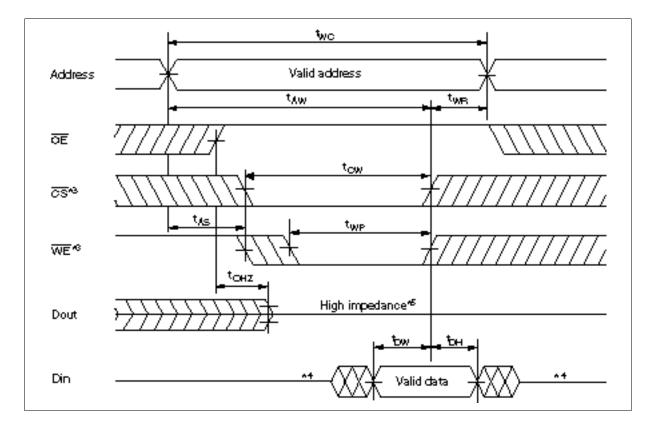
Read Timing Waveform (2) (WE =  $V_{IH},\,CS=V_{IL},\,OE=V_{IL})$ 



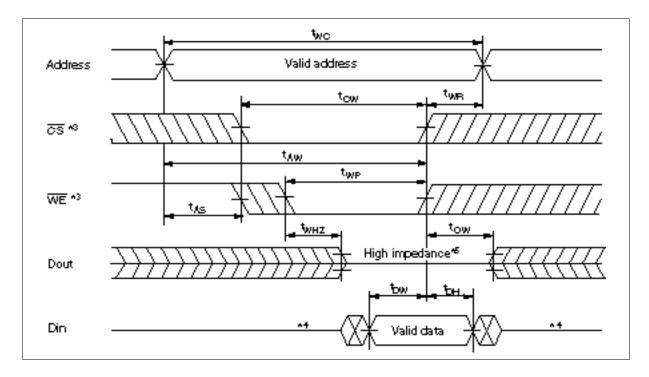
## Read Timing Waveform (3) (WE = $V_{IH}$ , CS = $V_{IL}$ , OE = $V_{IL}$ )\*<sup>2</sup>



## Write Timing Waveform (1) (WE Controlled)

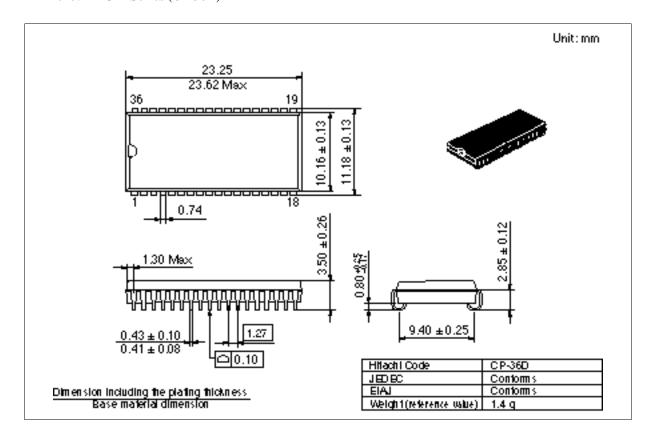


## Write Timing Waveform (2) (CS Controlled)



## **Package Dimensions**

#### HM628511HJPI Series (CP-36D)



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## **Revision Record**

Rev.	Date	ate Contents of Modification		Approved by	
1.0	Apr. 15, 1999	Initial issue			